## MC10E431, MC100E431

## 5 V ECL 3-Bit Differential Flip-Flop

## Description

The $\mathrm{MC} 10 \mathrm{E} / 100 \mathrm{E} 431$ is a 3-bit flip-flop with differential clock, data input and data output.

The asynchronous Set and Reset controls are edge-triggered rather than level controlled. This allows the user to rapidly set or reset the flip-flop and then continue clocking at the next clock edge, without the necessity of de-asserting the set/reset signal (as would be the case with a level controlled set/reset).

The E431 is also designed with larger internal swings, an approach intended to minimize the time spent crossing the threshold region and thus reduce the metastability susceptibility window.

The differential input structures are clamped so that the inputs of unused registers can be left open without upsetting the bias network of the device. The clamping action will assert the $\overline{\mathrm{D}}$ and the $\overline{\mathrm{CLK}}$ sides of the inputs. Because of the edge triggered flip-flop nature of the device simultaneously opening both the clock and data inputs will result in an output which reaches an unidentified but valid state. Note that the input clamps only operate when both inputs fall to 2.5 V below $\mathrm{V}_{\mathrm{CC}}$.

The $\mathrm{V}_{\mathrm{BB}}$ pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to $\mathrm{V}_{\mathrm{BB}}$ as a switching reference voltage. $\mathrm{V}_{\mathrm{BB}}$ may also rebias AC coupled inputs. When used, decouple $\mathrm{V}_{\mathrm{BB}}$ and $\mathrm{V}_{\mathrm{CC}}$ via a $0.01 \mu \mathrm{~F}$ capacitor and limit current sourcing or sinking to 0.5 mA . When not used, $\mathrm{V}_{\mathrm{BB}}$ should be left open.

The 100 Series contains temperature compensation.

## Features

- Edge-Triggered Asynchronous Set and Reset
- Differential D, CLK and Q; VBB Reference Available
- 1100 MHz Min. Toggle Frequency
- PECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$
with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
- Internal Input $50 \mathrm{k} \Omega$ Pulldown Resistors
- ESD Protection:
- > 2 kV Human Body Model
- > 200 V Machine Model
- > 2 kV Charged Device Model
- Meets or Exceeds JEDEC Spec EIA/JESD78 IC

Latchup Test

- Moisture Sensitivity: Level 3 (Pb-Free)
(For Additional Information, see Application Note AND8003/D)
- Flammability Rating: UL 94 V-0 @ 0.125 in,

Oxygen Index: 28 to 34

- Transistor Count $=348$ Devices
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

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PLCC-28
FN SUFFIX CASE 776-02

MARKING DIAGRAM*

$x x x=10$ or 100
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
G $\quad=$ Pb-Free Package
*For additional marking information, refer to Application Note AND8002/D.

## ORDERING INFORMATION

| Device | Package | Shipping $\dagger$ |
| :---: | :---: | :---: |
| MC10E431FNG | PLCC-28 <br> (Pb-Free) | 37 Units / Tube |
| MC10E431FNR2G | PLCC-28 <br> (Pb-Free) | 500 Tape \& Reel |
| MC100E431FNR2G | PLCC-28 <br> (Pb-Free) | 500 Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.


* All $\mathrm{V}_{\mathrm{CC}}$ and $\mathrm{V}_{\mathrm{CCO}}$ pins are tied together on the die.

Warning: All $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{CCO}}$, and $\mathrm{V}_{\mathrm{EE}}$ pins must be externally connected to Power Supply to guarantee proper operation.

Figure 1. Pinout: PLCC-28 (Top View)


Table 2. FUNCTION TABLE

| Dn | CLKn | Rn | Sn | Qn |
| :---: | :---: | :---: | :---: | :---: |
| L | Z | L | L | L |
| H | Z | L | L | H |
| X | X | Z | L | L |
| X | X | L | Z | H |

$Z=$ Low to high transition X = Don't Care

Figure 2. Logic Diagram

## MC10E431, MC100E431

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & V_{1} \leq V_{C C} \\ & V_{1} \geq V_{E E} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous Surge |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | mA |
| $\mathrm{I}_{\mathrm{BB}}$ | $\mathrm{V}_{\text {BB }}$ Sink/Source |  |  | $\pm 0.5$ | mA |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Temperature Range |  |  | 0 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{array}{\|l\|} \hline 0 \text { lfpm } \\ 500 \mathrm{lfpm} \end{array}$ | $\begin{array}{\|l\|l} \hline \text { PLCC-28 } \\ \text { PI CC-88 } \end{array}$ | $\begin{aligned} & 63.5 \\ & 43.5 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | PLCC-28 | 22 to 26 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) |  |  | 265 | ${ }^{\circ} \mathrm{C}$ |

[^0]Table 4. 10E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 110 | 132 |  | 110 | 132 |  | 110 | 132 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3980 | 4070 | 4160 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3050 | 3210 | 3370 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3830 | 3995 | 4160 | 3870 | 4030 | 4190 | 3940 | 4110 | 4280 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | 3050 | 3285 | 3520 | 3050 | 3285 | 3520 | 3050 | 3302 | 3555 | mV |
| $\mathrm{V}_{\text {BB }}$ | Output Voltage Reference | 3.62 |  | 3.74 | 3.65 |  | 3.75 | 3.69 |  | 3.81 | V |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.7 |  | 5.0 | 2.7 |  | 5.0 | 2.7 |  | 5.0 | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\mathrm{IHCMR}}$ min varies $1: 1$ with $\mathrm{V}_{\mathrm{EE}}$, max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.

Table 5. 10E SERIES NECL DC CHARACTERISTICS ( $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1$)$

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 110 | 132 |  | 110 | 132 |  | 110 | 132 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1020 | -930 | -840 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1950 | -1790 | -1630 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | -1170 | -1005 | -840 | -1130 | -970 | -810 | -1060 | -890 | -720 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | -1950 | -1715 | -1480 | -1950 | -1715 | -1480 | -1950 | -1698 | -1445 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | -1.38 |  | -1.27 | -1.35 |  | -1.25 | -1.31 |  | -1.19 | V |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | -2.3 |  | 0.0 | -2.3 |  | 0.0 | -2.3 |  | 0.0 | V |
| $\mathrm{I}_{\mathrm{H}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.065 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}} . \mathrm{V}_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\mathrm{IHCMR}}$ min varies $1: 1$ with $\mathrm{V}_{\mathrm{EE}}$, max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.

Table 6. 100E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $I_{\text {EE }}$ | Power Supply Current |  | 110 | 132 |  | 110 | 132 |  | 127 | 152 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3190 | 3295 | 3380 | 3190 | 3255 | 3380 | 3190 | 3260 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 3.62 |  | 3.74 | 3.62 |  | 3.74 | 3.62 |  | 3.74 | V |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | 2.7 |  | 5.0 | 2.7 |  | 5.0 | 2.7 |  | 5.0 | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\mathrm{EE}}$, max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.

Table 7. 100E SERIES NECL DC CHARACTERISTICS ( $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| IEE | Power Supply Current |  | 110 | 132 |  | 110 | 132 |  | 127 | 152 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1025 | -950 | -880 | -1025 | -950 | -880 | -1025 | -950 | -880 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1810 | -1705 | -1620 | -1810 | -1745 | -1620 | -1810 | -1740 | -1620 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | -1165 | -1025 | -880 | -1165 | -1025 | -880 | -1165 | -1025 | -880 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage (Single-Ended) | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | -1.38 |  | -1.26 | -1.38 |  | -1.26 | -1.38 |  | -1.26 | V |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) | -2.3 |  | 0.0 | -2.3 |  | 0.0 | -2.3 |  | 0.0 | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| ILL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\mathrm{IHCMR}}$ min varies $1: 1$ with $\mathrm{V}_{\mathrm{EE}}$, max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.

Table 8. AC CHARACTERISTICS $\left(\mathrm{V}_{C C x}=5.0 \mathrm{~V}\right.$; $\mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ or $\mathrm{V}_{C C x}=0.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic |  | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{f}_{\text {MAX }}$ | Maximum Toggle Frequency |  |  |  |  |  | 1.1 |  |  |  |  | GHz |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation Delay to Output CLK <br> R S |  | $\begin{aligned} & 550 \\ & 500 \\ & 500 \end{aligned}$ | $\begin{aligned} & 700 \\ & 725 \\ & 725 \end{aligned}$ | $\begin{aligned} & 850 \\ & 975 \\ & 975 \end{aligned}$ | $\begin{aligned} & 550 \\ & 550 \\ & 550 \end{aligned}$ | $\begin{aligned} & 700 \\ & 725 \\ & 725 \end{aligned}$ | $\begin{aligned} & 850 \\ & 925 \\ & 925 \end{aligned}$ | $\begin{aligned} & 550 \\ & 550 \\ & 550 \end{aligned}$ | $\begin{aligned} & 700 \\ & 725 \\ & 725 \end{aligned}$ | $\begin{aligned} & 850 \\ & 925 \\ & 925 \end{aligned}$ | ps |
| ts | Setup Time D R (Note 2) S (Note 2) |  | $\begin{aligned} & 250 \\ & 1100 \\ & 1100 \end{aligned}$ | $\begin{gathered} 0 \\ 700 \\ 700 \end{gathered}$ |  | $\begin{gathered} 200 \\ 1000 \\ 1000 \end{gathered}$ | $\begin{gathered} 0 \\ 700 \\ 700 \end{gathered}$ |  | $\begin{gathered} 200 \\ 1000 \\ 1000 \end{gathered}$ | $\begin{gathered} 0 \\ 700 \\ 700 \end{gathered}$ |  | ps |
| $\mathrm{t}_{\mathrm{H}}$ | Hold Time | D | 250 | 0 |  | 200 | 0 |  | 200 | 0 |  | ps |
| tpW | Minimum Pulse Width | CLK | 400 |  |  | 400 |  |  | 400 |  |  | ps |
| $\mathrm{t}_{\text {skew }}$ | Within-Device Skew (Note 3) |  |  | 50 |  |  |  |  |  | 50 |  | ps |
| $\mathrm{t}_{\text {IITTER }}$ | Random Clock Jitter (RMS) |  |  | <1 |  |  | < 1 |  |  | < 1 |  | ps |
| $\mathrm{V}_{\mathrm{PP}}$ | Input Voltage Swing (Differential Configuration) |  | 150 |  | 1000 | 150 |  | 1000 | 150 |  | 1000 | mV |
| $\mathrm{t}_{\mathrm{r}} / \mathrm{t}_{\mathrm{f}}$ | Rise/Fall Times (20-80\%) |  | 250 | 450 | 700 |  |  |  | 275 | 450 | 650 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. 10 Series: $V_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.

100 Series: VEE can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. These setup times define the minimum time the CLK or SET/RESET input must wait after the assertion of the RESET/SET input to assure the proper operation of the flip-flop.
3. Within-device skew is defined as identical transitions on similar paths through a device.

## MC10E431, MC100E431



Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices)

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V)
AN1503/D - ECLinPS $^{\text {M }}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family $^{\text {AN1568/D }}-$ Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10E431, MC100E431

## PACKAGE DIMENSIONS

28 LEAD PLLC
FN SUFFIX
CASE 776-02
ISSUE F



VIEW D-D



VIEW S

NOTES:

1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOPOF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE. 2. DIMENSION G1, TRUE POSITION TO BE 2. DIMENSION G1, TRUE POSITION IO BE
MEASURED AT DATUM -T-, SEATING PLANE.
. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 ( 0.250 ) PER SIDE.
2. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH
3. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE O.jTERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXTREMES OF THE PLASIIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR
BURRS, GATE BURRS AND INTERLEAD BURRS, GATE BURRS AND INTERLEAD
FLASH, BUT INCLUDING ANY MISMATCH FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
4. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

|  | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |
| A | 0.485 | 0.495 | 12.32 | 12.57 |
| B | 0.485 | 0.495 | 12.32 | 12.57 |
| C | 0.165 | 0.180 | 4.20 | 4.57 |
| E | 0.090 | 0.110 | 2.29 | 2.79 |
| F | 0.013 | 0.021 | 0.33 | 0.53 |
| G | 0.050 |  | BSC | 1.27 |
| BSC |  |  |  |  |
| H | 0.026 | 0.032 | 0.66 | 0.81 |
| J | 0.020 | --- | 0.51 | --- |
| K | 0.025 | --- | 0.64 | --- |
| R | 0.450 | 0.456 | 11.43 | 11.58 |
| U | 0.450 | 0.456 | 11.43 | 11.58 |
| V | 0.042 | 0.048 | 1.07 | 1.21 |
| W | 0.042 | 0.048 | 1.07 | 1.21 |
| X | 0.042 | 0.056 | 1.07 | 1.42 |
| Y | --- | 0.020 | --- | 0.50 |
| Z | $2^{\circ}$ | $10^{\circ}$ | $2^{\circ}$ | $10^{\circ}$ |
| G1 | 0.410 | 0.430 | 10.42 | 10.92 |
| K1 | 0.040 | --- | 1.02 | --- |

## MC10E431, MC100E431

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#### Abstract

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